

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/612,534	QIAN ET AL.	
Examiner	Art Unit	
John L. Goodrow	1756	

	SEARCHED				
Class	Subclass	Date	Examiner		
430	114	8/8/2005	JG		
	137.22				
	117				
	115				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor name search	8/8/2005	JG		
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